

## **HYBRID CONTENT ADDRESSABLE MEMORY**

### **FIELD OF THE INVENTION**

**[0001]** The present invention relates generally to content addressable memories. More particularly, the present invention relates to content addressable memory array architectures.

### **BACKGROUND OF THE INVENTION**

**[0002]** An associative memory system called Content Addressable Memory (CAM) has been developed to permit its memory cells to be referenced by their contents. Thus CAM has found use in lookup table implementations such as cache memory subsystems and is now rapidly finding use in networking system applications such as network address translation, pattern recognition, and data compression. CAM's most valuable feature is its ability to perform a search and compare of multiple locations as a single operation, in which search data is compared with data stored within the CAM. Typically search data is loaded onto search lines and compared with stored words in the CAM. During a search-and-compare operation, a match or mismatch signal associated with each stored word is generated on a matchline, indicating whether the search word matches a stored word or not.

**[0003]** A CAM stores data in a matrix of cells, which are typically SRAM based cells. However, to provide ternary state CAMs, ie. where each CAM cell can store one of three values: a logic "0", "1" or "don't care" result, ternary SRAM based cells require two binary SRAM cells.

**[0004]** A typical CAM block diagram is shown in Figure 1. The CAM 10 includes a matrix, or CAM memory array 25, of CAM cells (not shown) arranged in rows and columns. A predetermined number of CAM cells in a row store a word of data. An address decoder 17 is used to select any row within the CAM array 25 to allow data to be written into or read out of the selected row. Data access circuitry such as bitlines and column selection devices, are located within the array 25 to transfer data into and out of the array 25. Located within CAM array 25 for each row of CAM cells are matchline sense circuits, which are not shown, and are used during search-and-compare operations for outputting a result indicating a

successful or unsuccessful match of a search word against the stored word in the row. The results for all rows are processed by the priority encoder **22** to output the address (Match Address) corresponding to the location of a matched word. The match address is stored in match address registers **18** before being output by the match address output block **19**. Data is written into array **25** through the data I/O block **11** and the various data registers **15**. Data is read out from the array **25** through the data output register **23** and the data I/O block **11**. Other components of the CAM include the control circuit block **12**, the flag logic block **13**, the voltage supply generation block **14**, various control and address registers **16**, and JTAG block **21**.

**[0005]** Figure 2 depicts a hierarchical view of the typical CAM array **25**. CAM array **25** includes a matrix of CAM cells **30** and a matchline sense circuit block **26**. CAM cells **30** of the CAM array **25** are arranged in rows and columns. CAM cells **30** of a row are connected to a common matchline **ML<sub>i</sub>**, and CAM cells **30** of a column are connected to a common pair of search lines **SL<sub>j</sub>b/SL<sub>j</sub>** and a common pair of bitlines **BL<sub>j</sub>/BL<sub>j</sub>b**, where *i* is an integer value between 0 and *n*, and *j* is an integer value between 0 and *m*. While not shown to simplify the schematic, each row of CAM cells **30** is connected to a wordline, and those of skill in the art will understand that wordlines are required to ensure operability of the CAM cells **30**. Located adjacent to the CAM array **25** for each row is matchline sense circuit block **26**. Matchline sense circuit block **26** includes one matchline sense circuit **27** connected to a respective matchline **ML<sub>i</sub>**, and is used during search-and-compare operations for outputting match signals **ML\_OUT0-ML\_OUT<sub>n</sub>** which indicate a successful or unsuccessful match of a search word against the stored word. Although not shown in the simplified schematic of Fig. 2, the matchline sense circuits **27** also receive control signals to control their operation, and a person skilled in the art would understand that such control signals to be necessary for their proper operation of the circuit. While the bitlines are connected to well known bitline circuits, the searchlines in a CAM device **10** are connected to searchline drivers (not shown), such as those disclosed in commonly owned U.S. Patent No. 6,522,596.

**[0006]** Figures 3 through 5 show circuit schematics of the types of CAM cells **30** that can be used in the CAM array **25** of Figure 2. Figure 3 shows a typical ternary data SRAM type CAM cell, Figure 4 shows an alternate ternary SRAM type CAM cell, and Figure 5 shows a binary SRAM type CAM cell.

**[0007]** Figure 3 shows a typical ternary SRAM type CAM cell, referred to as a ternary SCAM cell from this point forward. SCAM cell 40 includes two well-known six-transistor SRAM cells 42 and 44, and a pair of search and compare stacks. Since both SRAM cells 42 and 44 are identical to each other, the following description of SRAM cell 42 will apply to SRAM cell 44. SRAM cell 42 includes a first access transistor 46 and a second access transistor 48 for coupling bitlines BLP and BLPb respectively, to the complementary nodes of cross coupled inverters 50 and 52 in response to an active WL signal. The first search and compare stack associated with SCAM cell 42 includes compare transistor 54 and search transistor 56 serially connected between the matchline ML and the tail-line TL. The gate terminal of compare transistor 54 is connected to a node of SRAM cell 42 while the gate terminal of search transistor 56 is connected to searchline SLb. Tail-line TL is typically coupled to a ground, or VSS power supply. The second search and compare stack associated with SRAM cell 44 includes compare transistor 58 and search transistor 60 serially connected between the matchline ML and the tail-line TL. The gate terminal of compare transistor 58 is connected to a node of SRAM cell 44 while the gate terminal of search transistor 60 is connected to searchline SL.

**[0008]** SCAM cell 40 includes a total of 16 transistors and stores encoded ternary data. Together, the two SRAM cells of SCAM cell 40 can store a ternary value representing logic "1", logic "0", or "don't care". Table 1 below shows an example of the ternary data encoding. Persons of skill in the art should understand that SCAM cell 40 can be implemented with n-channel transistors as shown in Figure 3, and/or p-channel transistors.

Table 1.

Ternary Value	SRAM Cell 42	SRAM Cell 44
0	0	1
1	1	0
"Don't Care"	0	0

**[0009]** Figure 4 shows an alternate type of ternary SCAM cell similar to the one shown in Figure 3. The presently shown ternary SCAM cell stores one bit of data and one

mask bit of data to block the search and compare results from affecting the matchline ML. SCAM cell 70 includes the previously described SRAM cells 42 and 44, and the search and compare stacks consisting of transistors 54, 56, 58 and 60. However, this SCAM cell 70 includes an additional mask transistor 72, and the gate terminal of compare transistor 58 is now connected to a storage node of SRAM cell 42 that is complementary to the storage node connected to the gate of compare transistor 54. Mask transistor 72 is connected between the source terminals of search transistors 56 and 60 and the tail line TL, and has its gate terminal connected to a storage node of SRAM cell 44. Accordingly, SCAM cell 70 consists of 17 transistors, implemented in n-channel and/or p-channel technology. SCAM cell 70 essentially functions as a searchable binary CAM cell with masking capability. More specifically, the comparison circuit is enabled if the mask bit stores a logic "0" and the comparison circuit is disabled if the mask bit stores a logic "1".

**[0010]** In applications where the mask bit is unnecessary, or where the data to be stored is only binary in nature, a typical binary SCAM cell can be used.

**[0011]** Figure 5 is a circuit schematic of a typical binary SCAM cell. Binary SCAM cell 80 uses the same SRAM cell 42 and search and compare stacks as seen in the previous ternary SCAM cell schematics, and includes a total of 10 transistors which can be implemented in n-channel and/or p-channel technology. Clearly, the absence of the second SRAM cell 44 and mask transistor 72 makes binary SCAM cell 80 smaller than previously shown ternary SCAM cells 40 and 70.

**[0012]** As previously mentioned, binary based CAM, and in particular binary SCAM, has found wide use in networking applications where data packets are transferred through the network according to the data in the header portion of the data packet. More specifically, network data packet routing and switching operations involve matching the header portion of the data packet with predetermined comparand data. While binary CAM can be used to match header data, it is limited to searching for exact matches between the comparand data and the header data having the same bit length headers. Therefore, binary CAM is not practical for use in systems that receive data packets having variable bit length headers.

**[0013]** However, the additional "don't care" state provided by ternary CAM permits partial match searches to be executed as the irrelevant bit positions can be set to the "don't care" state such that no comparison to the corresponding bit of comparand data occurs. This

capability is useful in modern network longest prefix matching operations, where only leading bits of the header portion are relevant for routing and switching.

**[0014]** Present ternary CAM chips are available in a 9M-bit density, meaning that the chip has approximately 9 million ternary CAM cells in its memory array arranged in rows and columns. A typical data packet can include a word of 144 bits stored by 144 ternary CAM cells in a row, or multiple 144-bit words stored in consecutive rows memory cells. With ternary data storage capability in each ternary CAM cell, the CAM chip can be used as a universal device for accommodating any data packet format because any number of ternary CAM cells can be reserved for header data.

**[0015]** However, it can be observed from progressive standardization of communication protocols and data packet formats that a specific number of bits of each data packet will only ever store binary data. Use of ternary CAM cells for storing only binary data is an inefficient use of silicon area because the unused storage cell of the ternary CAM cell cannot be used to store an unrelated bit of data, and use of ternary search circuits for performing binary searches unnecessarily wastes power.

**[0016]** Various schemes have been proposed in which ternary CAM cells can be dynamically configurable as binary CAM cells, such that the second data bit storage location of the ternary CAM cell can be used for storing another bit of data. Accordingly, the storage density of the CAM device memory array is effectively doubled. Unfortunately, such schemes require relatively complex CAM cell configurations which will further increase the size of the ternary CAM device memory array, and circuit overhead for controlling the operating mode of the configurable memory cells.

**[0017]** It is, therefore, desirable to provide a hybrid binary/ternary CAM device memory array that occupies minimal silicon area and consumes less power, while maintaining or improving CAM search and compare performance.

## **SUMMARY OF THE INVENTION**

**[0018]** It is an object of the present invention to obviate or mitigate at least one disadvantage of previous CAM device memory array architectures. In particular, it is an object of the present invention to minimize the size of the CAM device memory array that can efficiently store both binary and ternary data.

**[0019]** In a first aspect, the present invention provides a hybrid content addressable memory array. The hybrid content addressable memory array includes a first memory portion having a first type of content addressable memory cells arranged in rows and columns, and a second memory portion having a second type of content addressable memory cells arranged in rows and columns, where the second type of content addressable memory cells being electrically coupled to the first type of content addressable memory cells.

**[0020]** In an embodiment of the first aspect, the first memory portion and the second memory portion include matchlines, where each matchline of the first memory portion is coupled to the first type of content addressable memory cells, and each matchline of the second memory portion is coupled to the second type of content addressable memory cells. According to an aspect of the present embodiment, the first type of content addressable memory cells include ternary content addressable memory cells and the second type of content addressable memory cells include binary content addressable memory cells, and the matchlines of the first memory portion and the matchlines of the second memory portion are interleaved with each other.

**[0021]** According to further embodiments of the first aspect, the first type of content addressable memory cells can include binary content addressable memory cells, the second type of content addressable memory cells can include ternary content addressable memory cells, the first and the second type of content addressable memory cells include SRAM based binary content addressable memory cells and SRAM based ternary content addressable memory cells, and at least one of the first and the second type of content addressable memory cells include configurable ternary-binary content addressable memory cells.

**[0022]** According to another embodiment of the first aspect, the first type of content addressable memory cells and the second type of content addressable memory cells of a row are coupled to a logical matchline, where the logical matchline can include a segmented matchline having a first matchline segment and a second matchline segment. The first type of content addressable memory cells can be coupled to the first matchline segment and the second type of content addressable memory cells can be coupled to the second matchline segment. Alternatively, the first type of content addressable memory cells and the second

type of content addressable memory cells of a column can be coupled to common searchlines.

**[0023]** In a second aspect, the present invention provides a hybrid content addressable memory array having a first type of content addressable memory cells coupled to a logical matchline, and a second type of content addressable memory cells coupled to the logical matchline. The first type of content addressable memory cells can include binary content addressable memory cells and the second type of content addressable memory cells can include ternary content addressable memory cells, where the content addressable memory cells can be SRAM based.

**[0024]** According to an embodiment of the present aspect, the logical matchline includes a segmented matchline having at least two matchline segments, where the first type of content addressable memory cells are coupled to one of the at least two matchline segments and the second type of content addressable memory cells are coupled to the other of the at least two matchline segments.

**[0025]** In a third aspect, the present invention provides a hybrid content addressable memory array having a first type of content addressable memory cells coupled to common searchlines, and a second type of content addressable memory cells coupled to the common searchlines. The first type of content addressable memory cells can include binary content addressable memory cells and the second type of content addressable memory cells can include ternary content addressable memory cells, where the content addressable memory cells can be SRAM based.

**[0026]** Other aspects and features of the present invention will become apparent to those ordinarily skilled in the art upon review of the following description of specific embodiments of the invention in conjunction with the accompanying figures.

## **BRIEF DESCRIPTION OF THE DRAWINGS**

**[0027]** Embodiments of the present invention will now be described, by way of example only, with reference to the attached Figures, wherein:

Figure 1 is a block diagram of a typical DRAM based CAM chip;

Figure 2 is a circuit schematic of the memory array of Figure 1;

Figure 3 is a circuit schematic of an SRAM based ternary CAM cell;

Figure 4 is a circuit schematic of an alternate SRAM based ternary CAM cell;  
Figure 5 is a circuit schematic of an SRAM based binary CAM cell;  
Figure 6 is a hybrid CAM device memory array architecture according to an embodiment of the present invention;  
Figure 7 is a circuit schematic of the hybrid CAM device memory array of Figure 6;  
Figure 8 is a hybrid CAM device memory array architecture according to another embodiment of the present invention; and,  
Figure 9 is a circuit schematic of the hybrid CAM device memory array of Figure 8, and,  
Figure 10 is a schematic of a DRAM based ternary CAM cell.

## **DETAILED DESCRIPTION**

**[0028]** Generally, the present invention provides a content addressable memory array architecture that optimizes storage of binary-only and ternary data without additional circuit overhead. Furthermore, the embodiments of the present invention benefit from reduced power consumption and improved performance as a result of the optimized storage scheme for binary-only and ternary data.

**[0029]** As standardization of formats for network data packets develop, specific fields of the data packets can become constrained by rules of the standard. For example, header fields of data packets must not exceed a predetermined number of bits in length, where each bit position of the header field must be able to store one of three states. As previously mentioned, the three states in the CAM context include logic "1", logic "0" and "don't care" states. Other fields of the data packets, such as the data portion, are simply restricted to binary values. As most CAM devices use only ternary CAM cells, an in particular ternary SCAM cells, significant silicon area can be saved if ternary CAM cells used only for binary storage can be replaced with smaller binary CAM cells.

**[0030]** According to the embodiments of the present invention, a CAM device memory array is subdivided into at least two different portions, where each portion uses only



one particular type of CAM cell, and each portion is dedicated to storing a particular type of data.

**[0031]** Figure 6 is a schematic illustrating a CAM device memory array **100** according to a first embodiment of the present invention that stores each word of data in two different types of CAM cells. In the presently described embodiment, CAM device memory array **100** is subdivided into a binary CAM cell section **102** and a ternary CAM cell section **104**, where the CAM cells are disposed in rows and columns, where each row of CAM cells forms a word of data. Hence, each wordline and matchline is coupled to CAM cells in the binary section **102** and CAM cells in the ternary section **104**. In this particular example, ternary section **104** stores bit positions D0 to D71 of each word, and binary section **102** stores bit positions D72 to D143 of each word. However, the bit length of each section is not limited to the configuration shown in Figure 6. Therefore, since half of the CAM device memory array **100** consists of binary CAM cells, such as binary SCAM cells, the overall memory array size is significantly reduced over an equivalent density memory array consisting exclusively of ternary SCAM cells. Although CAM device memory array **100** is 144 bits wide and 64K rows long, a memory array of any dimension can be partitioned into a binary section and ternary section according to the embodiment of the present invention.

**[0032]** Figure 7 is a schematic showing the details of the CAM device memory array **100** illustrated in Figure 6. Matchlines **ML0** to **MLn** extend horizontally between the binary section **102** and the ternary section **104**, and are each coupled to a matchline sense circuit **106** for sensing a respective voltage level during a search and compare operation. As shown in Figure 7, the content addressable memory cells of binary section **102** and ternary section **104** are electrically coupled to each other via the common matchlines. Wordlines and tail lines are not shown to simplify the schematic, but those of skill in the art will understand that they are required for proper operation. Each matchline sense circuit **106** provides a matchline output **ML\_OUT** representing a match or mismatch condition of its corresponding matchline. Each matchline is coupled to binary CAM cells **90** in binary section **102** and ternary CAM cells **92** in ternary section **104**. It is noted that binary CAM cell **90** can be implemented with the circuit configuration of binary SCAM cell **80**, and ternary CAM cell **92** can be implemented with the circuit configuration of either ternary SCAM cells **40** or **70** shown in Figures 3 and 4 respectively. . It should be apparent to those of skill in the art that

binary CAM cells **90** in binary section **102** minimizes silicon area consumption since each binary CAM cell **90** uses fewer transistors than each ternary CAM cell **92**. Therefore, CAM device memory array **100** maximizes silicon area efficiency because smaller sized binary CAM cells are used to store data that will only be binary in format. It is noted that binary CAM cells **90** can have a layout optimized to minimize column pitch. Hence silicon area along the row direction can be further conserved.

**[0033]** Advantages of the present embodiment are as follows. The reduced row length of each matchline translates into reduced capacitance thereof. Therefore, the performance of each matchline is enhanced while overall power consumption is reduced.

**[0034]** While the embodiments of the present invention shown in Figures 6 and 7 partition the CAM device memory array by columns, the memory array can be partitioned by rows according to an alternate embodiment of the present invention.

**[0035]** Figure 8 is a schematic illustrating a CAM device memory array **110** according to a second embodiment of the present invention, with the memory array partitioned into different portions by rows. It is noted that for the purposes of illustrating the present embodiment, CAM device memory array **110** has the same number of rows and columns as CAM device memory array **100** shown in Figure 6. In the presently described embodiment, CAM device memory array **110** is subdivided into a ternary CAM cell section **112** and a binary CAM cell section **114**, where the CAM cells are disposed in rows and columns, where each row of CAM cells forms a word of data. As shown in Figure 8, ternary CAM cell section **112** occupies 16K rows while binary CAM cell section **114** occupies 48K rows. As will be shown in Figure 9, each row includes the same type of CAM cell.

**[0036]** Figure 9 is a schematic showing the details of the CAM device memory array **110** illustrated in Figure 8. Matchlines **ML0** and **ML1** are part of the ternary CAM section **114**, and are each coupled to ternary CAM cells **92** and a respective matchline sense circuit **116**. Each matchline sense circuit **116** is analogous to matchline sense circuit **106** of Figure 7, therefore further description of its operation is not necessary. Matchlines **MLn-1** and **MLn** are part of the binary CAM section **112**, and are each coupled to binary CAM cells **90** and a respective matchline sense circuit **116**. As in Figure 7, wordlines and tail lines are not shown to simplify the schematic, and the same binary CAM cells **90** and ternary CAM cells **92** can be used. It is noted that each pair of complementary searchlines and bitlines extend vertically

between both the binary CAM section **112** and the ternary CAM section **114** such that the ternary CAM cells **92** and binary CAM cells **90** coupled to the same bitline and searchline form one column of CAM cells. Therefore, the content addressable memory cells of binary section **112** and ternary section **114** are electrically coupled to each other via the common bitlines and searchlines. For example, ternary CAM cells **92** and binary CAM cells **90** coupled to **SL0b** and **BL0** are part of the same column of CAM cells. In this particular embodiment, binary CAM cells **90** have been optimized in layout to minimize its footprint along the bitline direction, hence the overall area occupied by CAM device memory array **110** can be minimized along the bitline direction since the pitch of each row of binary CAM cells **90** in the binary CAM section **112** can be made smaller than the pitch of each row of ternary CAM cells **92** in ternary CAM section **114**. Therefore, an advantage resulting from the reduced bitline and searchline length is the reduced corresponding capacitance. Therefore, bitline and searchline drive circuit performance can be improved while reducing overall power consumption.

**[0037]** While the embodiments of the present invention have shown the CAM device memory array partitioned into two memory portions, the memory array can be partitioned into any number of memory portions to suit the particular application.

**[0038]** The operation of CAM device memory arrays **100** and **110** according to the embodiments of the present invention, will be analogous to the operation of CAM array **25**. More specifically, once search data has been driven onto the searchlines, each CAM cell **90/92** compares its stored data against the searchline data to affect the matchline if a mismatch condition exists.

**[0039]** In the embodiment of the invention shown in Figure 9, the system may execute a search for binary data stored only in binary section **112**, or for ternary data stored in ternary section **114**. Although the searchlines are coupled to both the binary section **112** and ternary section **114**, the system will have knowledge of those physical rows in each section. More specifically, the results provided by the matchline sense circuits **116** corresponding to results that are undesired can be masked out. For example, this can be done by disabling the matchline sense circuits **116** that correspond to either the binary section **112** during a ternary data search, or the ternary section **114** during a binary data search.

**[0040]** According to another embodiment of the present invention, the CAM device memory array **100** can have segmented matchlines, where each matchline segment of the same row is coupled to different types of CAM cells. Accordingly, each matchline segment of the same row belong to the same logical matchline. Matchline segmentation is disclosed and taught in commonly owned U.S. Patent No. 6,584,003, the contents of which are incorporated herein by reference, as a technique to reduce power consumption in a CAM device memory array. For example, a first matchline segment of a row of CAM cells can be coupled only to binary CAM cells **90**, and a second matchline segment of the row of CAM cells can be coupled only to ternary CAM cells **92**. Alternatively, each matchline segment can be coupled to groups of binary CAM cells **90** and ternary CAM cells **92**. Those of skill in the art will appreciate that each row can be configured to include any number of matchline segments.

**[0041]** While the previous embodiments of the present invention shown in Figures 7 and 9 show the CAM device memory array **100** as having two different CAM memory cell sections, additional CAM memory cell sections can be included. For example, CAM device memory array **100** can include several CAM memory cell sections interleaved with each other, where each section can include any number of rows or columns of CAM memory cells. Hence, the CAM device memory array **100** can be seen as including two logical CAM memory cell blocks having rows or columns, or small groups of rows or columns, interleaved with other.

**[0042]** An alternate embodiment where one or more ternary rows of CAM memory cells is interleaved with one or more binary rows of CAM memory cells can be used in very wide word applications where a word spans more than one physical row of CAM memory cells. In one such an embodiment, each row of ternary CAM cells can be followed by three rows of binary CAM cells. Descriptions of wide word applications are available in commonly owned U.S. Patent No. 6,708,250 and commonly owned U.S. Patent Application No. 10/357,270.

**[0043]** In a further alternate embodiment of the invention shown in Figures 6 and 7, the ternary section **104** can include another section of cells, consisting of columns of configurable ternary-binary CAM cells adjacent to the binary section **102** so that the width of ternary section **104** can be dynamically configurable. Alternatively, the entire ternary section

**104** can consist of configurable ternary-binary CAM cells. Examples of configurable ternary-binary CAM cells are shown in U.S. Patent No. 6,108,227 and 6,362,992. Persons of skill in the art will understand how to incorporate such cells into the embodiments of the present invention. Therefore, significant silicon area savings can be realized by employing the previously described embodiments of the present invention. Preferably, ternary CAM cell sections of the CAM device memory array include ternary SCAM cells while binary CAM cell sections include binary SCAM cells, to maximize silicon area savings.

**[0044]** While binary and ternary SCAM cells are preferably used in the binary and ternary sections of the CAM device memory array, DRAM based binary and ternary CAM cells, referred to as a ternary or binary DCAM cells from this point forward, can be used instead.

**[0045]** Figure 10 shows a typical ternary DCAM cell **200** as described in Canadian Patent Application No. 2,266,062, filed March 31, 1999, the contents of which are incorporated herein by reference. DCAM cell **200** has a comparison circuit that includes an n-channel search transistor **202** connected in series with an n-channel compare transistor **204** between a matchline **ML** and a tail line **TL**. A search line **SL** is connected to the gate of search transistor **202**. The storage circuit includes an n-channel access transistor **206** having a gate connected to a wordline **WL** and connected in series with capacitor **208** between bitline **BL** and a cell plate voltage potential **VCP**. Charge storage node **CELL1** is connected to the gate of compare transistor **204** to turn on transistor **204** if there is charge stored on capacitor **208** i.e. if **CELL1** is logic "1". The remaining transistors and capacitor replicate transistors **202**, **204**, **206** and capacitor **208** for the other half of the ternary data bit, and are connected to corresponding lines **SLb** and **BLb** and are provided to support ternary data storage. Further description of the ternary DCAM cell **200** is detailed in the aforementioned reference. It is noted that a binary DCAM version of the ternary DCAM cell **200** is identical to ternary DCAM cell **200**, since complementary data states of a single bit of data are necessary for executing a binary search and compare operation. Therefore, ternary DCAM cell **200** can store either binary or ternary data.

**[0046]** Therefore, according to another embodiment of the present invention, CAM device memory arrays **100** and **110** can include ternary and binary DCAM cells in their binary and ternary sections respectively. More specifically, DCAM cells **200** in the ternary section

stores ternary data while DCAM cells **200** in the binary section stores binary data. Control logic therefore determines the particular columns of DCAM cells **200** that should have binary data or ternary data written to them. The control logic also determines the appropriate type of search, ie. binary or ternary search, to be applied to specific columns.

**[0047]** The above-described embodiments of the present invention are intended to be examples only. Alterations, modifications and variations may be effected to the particular embodiments by those of skill in the art without departing from the scope of the invention, which is defined solely by the claims appended hereto.